TOSHIBA Diode Silicon Epitaxial Planar Type

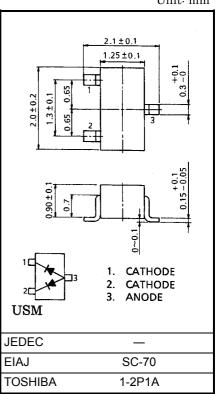
# **1SS300**

#### Ultra High Speed Switching Applications

- Small package : SC-70
- Low forward voltage  $: V_{F(3)} = 0.92V (typ.)$
- Fast reverse recovery time: trr = 1.6ns (typ.)
- Small total capacitance  $: C_T = 2.2 pF (typ.)$

#### Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit	
Maximum (peak) reverse voltage	V <sub>RM</sub>	85	V	
Reverse voltage	V <sub>R</sub>	80	V	
Maximum (peak) forward current	I <sub>FM</sub>	300 (*)	mA	
Average forward current	Ι <sub>Ο</sub>	100 (*)	mA	
Surge current (10ms)	I <sub>FSM</sub>	2 (*)	А	
Power dissipation	Р	100	mW	
Junction temperature	Тј	125	°C	
Storage temperature	T <sub>stg</sub>	-55~125	°C	



\*: Unit rating. Total rating = unit rating × 1.5



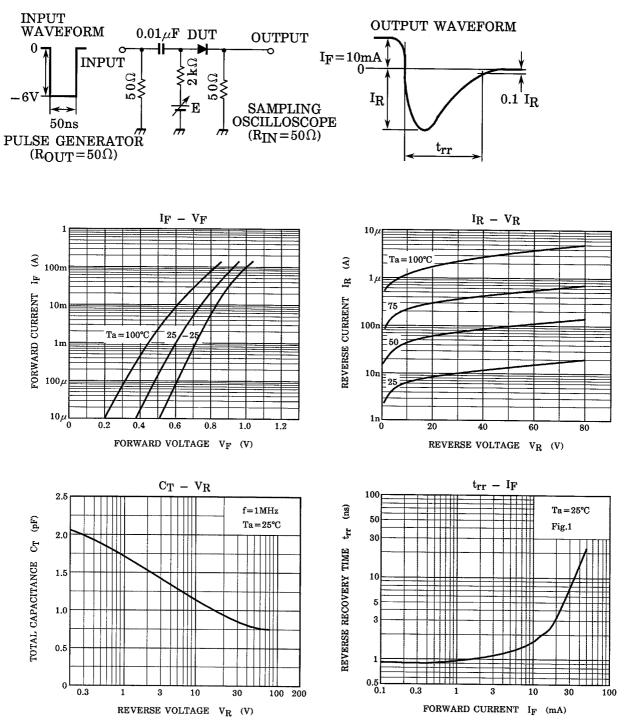
### Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Forward voltage	V <sub>F (1)</sub>	_	I <sub>F</sub> = 1mA	_	0.61	_	
	V <sub>F (2)</sub>	_	I <sub>F</sub> = 10mA	_	0.74	_	V
	V <sub>F (3)</sub>	_	I <sub>F</sub> = 100mA	_	0.92	1.20	
Reverse current	I <sub>R (1)</sub>	-	V <sub>R</sub> = 30V	-	_	0.1	μA
	I <sub>R (2)</sub>	_	V <sub>R</sub> = 80V		—	0.5	
Total capacitance	CT	—	V <sub>R</sub> = 0, f = 1MHz		2.2	4.0	pF
Reverse recovery time	t <sub>rr</sub>	_	I <sub>F</sub> = 10mA, Fig.1		1.6	4.0	ns

Unit: mm

## **TOSHIBA**

### Fig.1 Reverse Recovery Time (t<sub>rr</sub>) Test Circuit Marking



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